## Search Notes



Application/Control No.	Applicant(s)/Patent Under Reexamination
10594695	AKIYAMA ET AL.
Examiner	Art Unit
Q. JANICE LI	1633

SEARCHED			
Class	Subclass	Date	Examiner
N.D.		20100125	QJL

SEARCH NOTES		
Search Notes	Date	Examiner
Palm Inventor	20090706	QJL
STN		
sequence databases		
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INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
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